Unit: mm

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSV)

2SK3445

Switching Regulator, DC-DC Converter Applications Motor Drive Applications

- Low drain-source ON resistance: $RDS(ON) = 90 \text{ m}\Omega \text{ (typ.)}$
- High forward transfer admittance: $|Y_{fs}| = 10 \text{ S (typ.)}$
- Low leakage current: $I_{DSS} = 100 \,\mu\text{A} \,(V_{DS} = 250 \,\text{V})$
- Enhancement mode: $V_{th} = 3.0 \text{ to } 5.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$

Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit		
Drain-source voltage		V_{DSS}	250	V		
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V_{DGR}	250	V		
Gate-source voltage		V _{GSS}	±30	V		
Drain current	DC	(Note 1)	I _D	20	Α	
Dialii cuiteiit	Pulse	(Note 1)	I _{DP}	80		
Drain power dissipation (Tc = 25°C)		P_{D}	125	W		
Single pulse avalanche energy (Note 2)		E _{AS}	487	mJ		
Avalanche current		I _{AR}	20	Α		
Repetitive avalanche energy (Note 3)		E _{AR}	12.5	mJ		
Channel temperature	Э		T _{ch}	150	°C	
Storage temperature	range		T _{stg}	-55~150	°C	

9.2 max

7.0±0.2

9.2 max

7.0±0.2

9.2 max

8 max

9.2 max

8 max

9.2 max

8 max

9.2 max

9.2 max

8 max

9.2 max

9.2 max

8 max

9.2 max

9.3 max

9.4 max

9.4

2. SOURCE 1: S1 3. SOURCE 2: S2

4. DRAIN : D

JEDEC	_
JEITA	SC-97
TOSHIBA	2-9F1B

Weight: 0.74 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	1.00	°C/W

Notice:

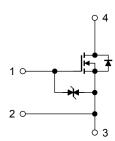
Please use the S1 pin for gate input signal return. Make sure that the main current flows into the S2 pin.

Note 1: Ensure that the channel temperature does not exceed 150°C.

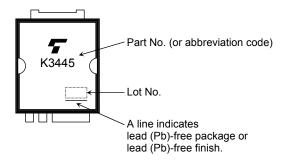
Note 2: $V_{DD} = 50$ V, $T_{ch} = 25$ °C (initial), L = 2.06 mH, $I_{AR} = 20$ A, $R_G = 25$ Ω

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Please handle with caution.



Marking



Electrical Characteristics (Note 4) (Ta = 25°C)

Cha	aracteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage curr	rent	I _{GSS}	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μΑ
Drain cut-off curre	ent	I _{DSS}	V _{DS} = 250 V, V _{GS} = 0 V	_	_	100	μА
Drain-source brea	akdown voltage	V _{(BR) DSS}	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	250	_	_	V
Gate threshold vo	ltage	V _{th}	$V_{DS} = 10 \text{ V}, I_D = 1 \text{ mA}$	3.0	_	5.0	V
Drain-source ON	resistance	R _{DS} (ON)	V _{GS} = 10 V, I _D = 10 A	_	90	105	mΩ
Forward transfer	admittance	Y _{fs}	V _{DS} = 10 V, I _D = 10 A	5	10	_	S
Input capacitance	:	C _{iss}		_	2090	_	
Reverse transfer capacitance		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	280	_	pF
Output capacitano	се	Coss		_	1000	_	
Output capacitance C_{OSS} — 10 V_{OS} C_{OSS} C_{OSS} — 10 V_{OSS} C_{OSS} $C_$	Rise time	t _r	V _{GS} 10 V	_	20	_	
	40	_					
Switching time	Fall time	t _f	R _L = 12	_	10		ns
	Turn-off time	t _{off}	Duty \leq 1%, $t_W = 10 \mu s$ $V_{DD} \simeq 125 V$	_	40	_	
Total gate charge (gate-source plus		Qg	V _{DD} ≈ 200 V, V _{GS} = 10 V,	_	45	_	
Gate-source charge		Q _{gs}	$I_D = 200 \text{ A}$	_	22	_	nC
Gate-drain ("mille	r") charge	Q _{gd}		_	23	_	

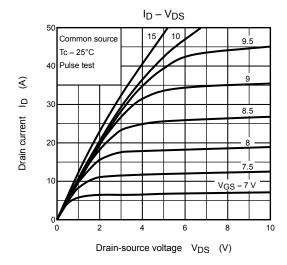
Note 4: Connect the S1 pin and S2 pin together, then ground them except during switching time measurement.

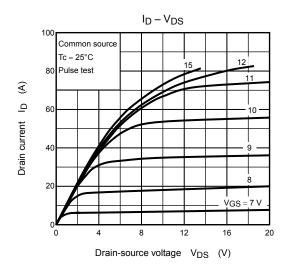
Source-Drain Ratings and Characteristics (Note 5) (Ta = 25°C)

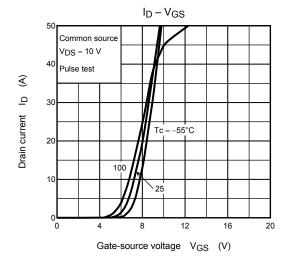
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1, Note 5)	I _{DR} 1	_	_	_	20	Α
Pulse drain reverse current (Note 1, Note 5)	I _{DRP} 1	_			80	Α
Continuous drain reverse current (Note 1, Note 5)	I _{DR} 2	_	_	_	1	Α
Pulse drain reverse current (Note 1, Note 5)	I _{DRP} 2	_			4	Α
Forward voltage (diode)	V _{DS2F}	I _{DR1} = 20 A, V _{GS} = 0 V	_	_	-1.5	٧
Reverse recovery time	t _{rr}	I _{DR} = 20 A, V _{GS} = 0 V, dI _{DR} /dt = 100 A/μs	_	320	_	ns
Reverse recovery charge	Q_{rr}	dl _{DR} /dt = 100 A/μs	_	2.8	_	μС

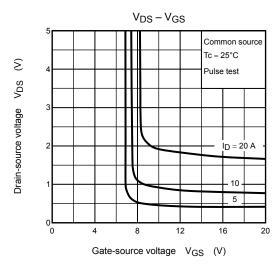
Note 5: I_{DR}1, I_{DRP}1: Current flowing between the drain and the S2 pin. Ensure that the S1 pin is left open. I_{DR}2, I_{DRP}2: Current flowing between the drain and the S1 pin. Ensure that the S2 pin is left open.

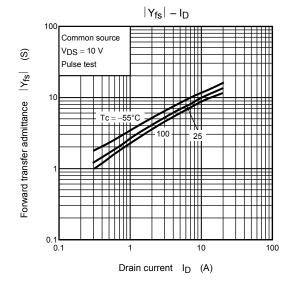
Unless otherwise specified, connect the S1 and S2 pins together, and ground them.

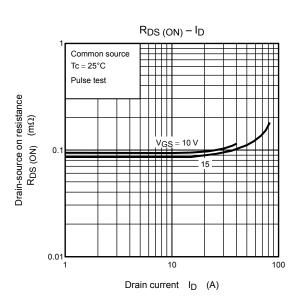


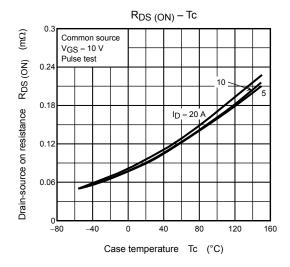


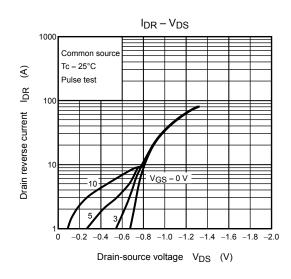


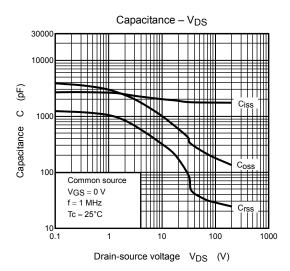


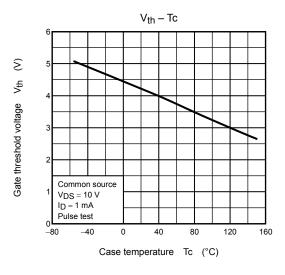


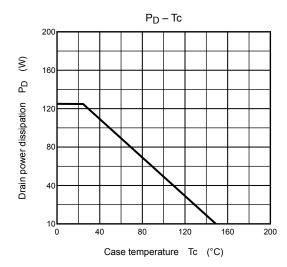


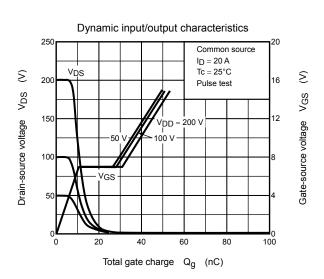


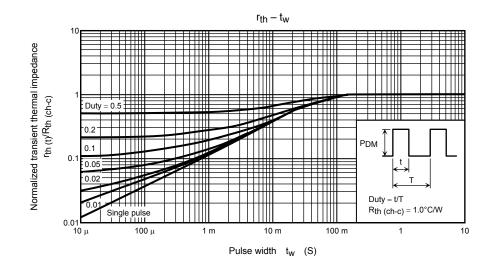


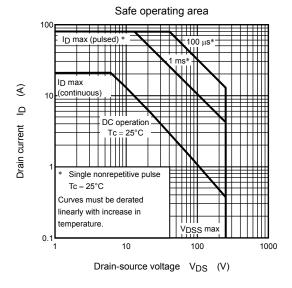


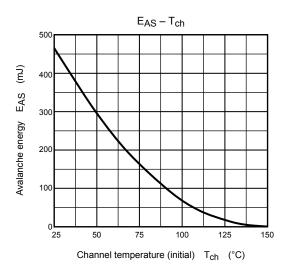


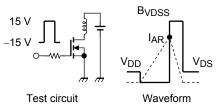












$$\begin{aligned} &R_G = 25~\Omega \\ &V_{DD} = 50~V,~L = 2.06~mH \end{aligned} \qquad E_{AS} = \frac{1}{2} \cdot L \cdot I^2 \cdot \left(\frac{BVDSS}{BVDSS - VDD} \right)$$

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20070701-EN

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